

<b>Search Notes</b> 				<b>Application/Control No.</b> 09/920,983 <b>Examiner</b> Huyen X. Vo	<b>Applicant(s)/Patent under Reexamination</b> HAASE ET AL.	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner			
704	207-210; 213-220	2/22/2006	HV			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			